

Application No.	Applicant(s)
10/021,531	PHAN ET AL.
Examiner	Art Unit
Binh X Tran	1765

	SEARCHED					
Class	Subclass	Date	Examiner			
156	345.24	7/1/2004	Bt			
156	345.25	7/1/2004	3			
156	345.26	7/1/2004	BT			
156	345.33	7/1/2004	町			
156	345.51	7/1/2004	KT			
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INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
156	345.24	7/1/2004	制		
156	345.25	7/1/2004	Bi		
156	345.26	7/1/2004	MT		
	345.33 345.51	7/1/2004	15+		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
Update keywords and inventors' name search using EAST	7/1/2004	ら ナ			
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